Notice of References Cited

Application/Control No. 10/615,915	Applicant(s)/Patent Under Reexamination YAMAZAWA ET AL.	
Examiner	Art Unit	
Rakesh K. Dhingra	1763	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,199,505	03-2001	Sato et al.	118/723E
	В	US-5,474,648	12-1995	Patrick et al.	438/10
	С	US-6,252,354	06-2001	Collins et al.	315/111.51
	D	US-6,884,635	04-2005	Parsons, Richard	438/10
	E	US-2001/0009139	07-2001	Shan et al.	118/723.00E
	F	US-4,340,461	07-1982	Hendricks et al.	204/298.33
	G	US-6,631,693	10-2003	Hilliker, Stephen E.	118/723E
	Н	US-6,270,618	08-2001	Nákano et al.	156/345.44
	1	US-6,485,602	11-2002	Hirose, Eiji	156/345.44
ı	J	US-6,174,450	01-2001	Patrick et al.	216/61
	κ	US-5,815,047	09-1998	Sorensen et al.	333/17.3
	L	US-6,812,646	11-2004	Windhorn et al.	315/111.21
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р				·	
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	>	
	8	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.